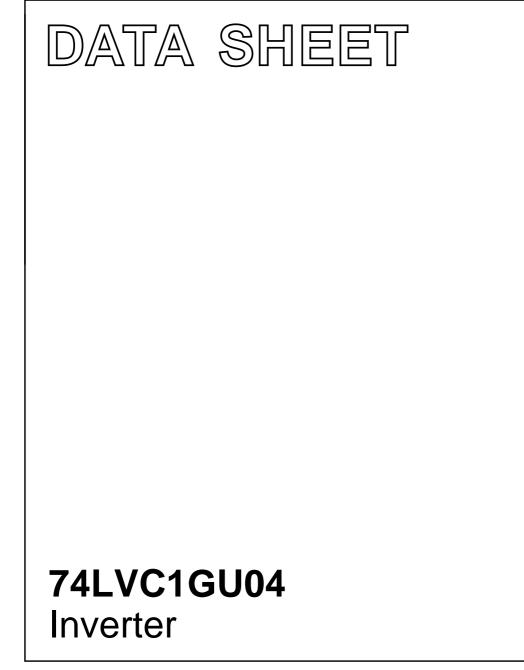
## INTEGRATED CIRCUITS



Product specification Supersedes data of 2000 Dec 12 File under Integrated Circuits, IC24 2001 Apr 06



## 74LVC1GU04

#### FEATURES

- Wide supply voltage range from 1.65 to 5.5 V
- High noise immunity
- Complies with JEDEC standard:
  - JESD8-7 (1.65 to 1.95 V)
  - JESD8-5 (2.3 to 2.7 V)
  - JESD8B/JESD36 (2.7 to 3.6 V).
- ±24 mA output drive (V<sub>CC</sub> = 3.0 V)
- CMOS low power consumption
- Latch-up performance exceeds 250 mA
- Input accepts voltages up to 5 V
- SOT353 package.

#### QUICK REFERENCE DATA

Ground = 0 V;  $T_{amb}$  = 25 °C;  $t_r$  =  $t_f \le 2.5$  ns.

#### DESCRIPTION

The 74LVC1GU04 is a high-performance, low-power, low-voltage, Si-gate CMOS device, superior to most advanced CMOS compatible TTL families.

The input can be driven from either 3.3 or 5 V devices. This feature allows the use of this device in a mixed 3.3 and 5 V environment.

The 74LVC1GU04 provides the inverting single state unbuffered function.

SYMBOL	PARAMETER	CONDITIONS	TYPICAL	UNIT
t <sub>PHL</sub> /t <sub>PLH</sub>	propagation delay A to Y	$V_{CC}$ = 1.8 V; C <sub>L</sub> = 30 pF; R <sub>L</sub> = 1 k $\Omega$	1.7	ns
		$V_{CC} = 2.5 \text{ V}; C_L = 30 \text{ pF}; R_L = 500 \Omega$	1.3	ns
		$V_{CC} = 3.3 \text{ V}; \text{ C}_{L} = 50 \text{ pF}; \text{ R}_{L} = 500 \Omega$	1.6	ns
		$V_{CC} = 5.0 \text{ V}; \text{ C}_{L} = 50 \text{ pF}; \text{ R}_{L} = 500 \Omega$	1.3	ns
CI	input capacitance		6	pF
C <sub>PD</sub>	power dissipation capacitance per buffer	notes 1 and 2	14.9	pF

#### Notes

1.  $C_{PD}$  is used to determine the dynamic power dissipation ( $P_D$  in  $\mu W$ ).

 $P_D = C_{PD} \times V_{CC}^2 \times f_i + (C_L \times V_{CC}^2 \times f_o)$  where:

 $f_i$  = input frequency in MHz;

 $f_o = output frequency in MHz;$ 

 $C_L$  = output load capacitance in pF;

 $V_{CC}$  = supply voltage in Volts.

2. The condition is  $V_I = GND$  to  $V_{CC}$ .

#### FUNCTION TABLE

See note 1.

INPUT	OUTPUT
A	Y
L	Н
Н	L

#### Note

1. H = HIGH voltage level;

L = LOW voltage level.

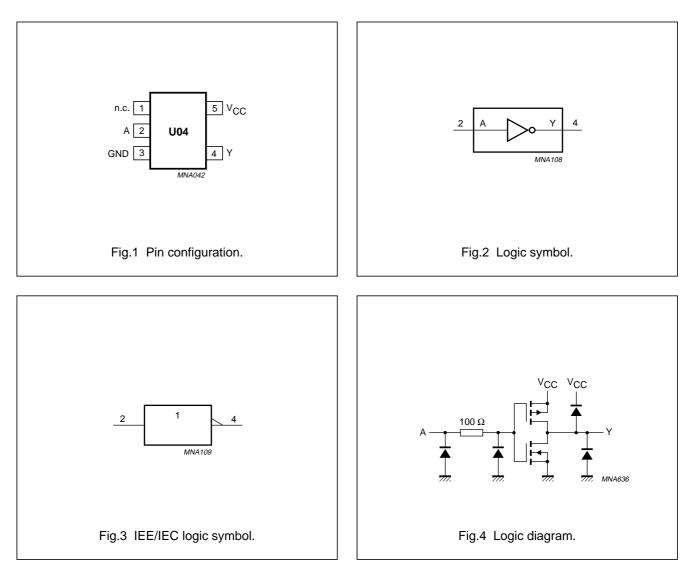
## 74LVC1GU04

#### ORDERING INFORMATION

			PACKAGE	E						
TYPE NUMBER	TEMPERATURE RANGE	PINS	PACKAGE	MATERIAL	CODE	MARKING				
74LVC1GU04GW	–40 to +85 °C	5	SC-88A	plastic	SOT353	VD				

#### PINNING

PIN	SYMBOL	DESCRIPTION
1	n.c.	not connected
2	A	data input A
3	GND	ground (0 V)
4	Y	data output Y
5	V <sub>CC</sub>	supply voltage



## 74LVC1GU04

#### **RECOMMENDED OPERATING CONDITIONS**

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V <sub>CC</sub>	supply voltage		1.65	5.5	V
VI	input voltage		0	5.5	V
Vo	output voltage		0	V <sub>CC</sub>	V
T <sub>amb</sub>	operating ambient temperature		-40	+85	°C
t <sub>r</sub> , t <sub>f</sub>	input rise and fall times	$V_{CC}$ = 1.65 to 2.7 V	0	20	ns/V
		$V_{CC}$ = 2.7 to 5.5 V	0	10	ns/V

#### LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 60134); voltages are referenced to GND (ground = 0 V).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V <sub>CC</sub>	supply voltage		-0.5	+6.5	V
I <sub>IK</sub>	input diode current	V <sub>1</sub> < 0	_	-50	mA
VI	input voltage	note 1	-0.5	+6.5	V
I <sub>OK</sub>	output diode current	$V_{\rm O} > V_{\rm CC}$ or $V_{\rm O} < 0$	_	±50	mA
Vo	output voltage	note 1	-0.5	V <sub>CC</sub> + 0.5	V
lo	output source or sink current	$V_0 = 0$ to $V_{CC}$	_	±50	mA
I <sub>CC</sub> , I <sub>GND</sub>	V <sub>CC</sub> or GND current		-	±100	mA
T <sub>stg</sub>	storage temperature		-65	+150	°C
P <sub>D</sub>	power dissipation per package	for temperature range from -40 to +85 °C; note 2	_	200	mW

#### Notes

- 1. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.
- 2. Above 55 °C the value of  $\mathsf{P}_\mathsf{D}$  derates linearly with 2.5 mW/K.

## 74LVC1GU04

#### DC CHARACTERISTICS

At recommended operating conditions; voltage are referenced to GND (ground = 0 V).

		TEST CONDITION	NS		T <sub>amb</sub> (°C	)	
SYMBOL	PARAMETER	OTUED	V 00	-	–40 to +85		
		OTHER V <sub>CC</sub> (V)	MIN.	<b>TYP.</b> <sup>(1)</sup>	MAX.	1	
V <sub>IH</sub>	HIGH-level input voltage		1.65 to 5.5	$0.75 \times V_{CC}$	-	-	V
V <sub>IL</sub>	LOW-level input voltage		1.65 to 5.5	-	-	$0.25 \times V_{CC}$	V
V <sub>OL</sub>	LOW-level	$V_{I} = V_{IH} \text{ or } V_{IL}; I_{O} = 100 \ \mu\text{A}$	1.65 to 5.5	-	-	0.1	V
	output voltage	$V_{I} = V_{IH} \text{ or } V_{IL}; I_{O} = 4 \text{ mA}$	1.65	-	-	0.45	V
		$V_{I} = V_{IH} \text{ or } V_{IL}; I_{O} = 8 \text{ mA}$	2.3	-	-	0.3	V
		$V_{I} = V_{IH} \text{ or } V_{IL}; I_{O} = 12 \text{ mA}$	2.7	-	-	0.4	V
		$V_{I} = V_{IH} \text{ or } V_{IL}; I_{O} = 24 \text{ mA}$	3.0	_	-	0.55	V
		$V_{I} = V_{IH} \text{ or } V_{IL}; I_{O} = 32 \text{ mA}$	4.5	-	-	0.55	V
V <sub>OH</sub>	HIGH-level	$V_I = V_{IH} \text{ or } V_{IL}; I_O = -100 \ \mu \text{A}$	1.65 to 5.5	V <sub>CC</sub> - 0.1	-	-	V
	output voltage	$V_I = V_{IH} \text{ or } V_{IL}; I_O = -4 \text{ mA}$	1.65	1.2	-	-	V
		$V_{I} = V_{IH} \text{ or } V_{IL}; I_{O} = -8 \text{ mA}$	2.3	1.9	-	-	V
		$V_{I} = V_{IH} \text{ or } V_{IL}; I_{O} = -12 \text{ mA}$	2.7	2.2	-	-	V
		$V_{I} = V_{IH} \text{ or } V_{IL}; I_{O} = -24 \text{ mA}$	3.0	2.3	-	-	V
		$V_{I} = V_{IH} \text{ or } V_{IL}; I_{O} = -32 \text{ mA}$	4.5	3.8	-	-	V
l <sub>LI</sub>	input leakage current	V <sub>1</sub> = 5.5 V or GND	3.6	-	±0.1	±5	μA
I <sub>CC</sub>	quiescent supply current	$V_I = V_{CC}$ or GND; $I_O = 0$	5.5	-	0.1	10	μA

#### Note

1. All typical values are measured at V\_{CC} = 3.3 V and T\_{amb} = 25 °C.

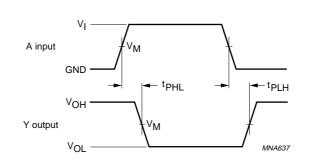
## 74LVC1GU04

## AC CHARACTERISTICS

GND = 0 V;  $t_r = t_f \le 2.0$  ns.

		TEST CONE	DITIONS		T <sub>amb</sub> (°C)		
SYMBOL	PARAMETER	WAVEFORMS			-40 to +8	35	UNIT
		WAVEFORMS V <sub>CC</sub> (V)	MIN.	TYP.	MAX.		
t <sub>PHL</sub> /t <sub>PLH</sub>	propagation delay A to Y	see Figs 5 and 8	1.65 to 1.95	0.3	1.7	5.0	ns
			2.3 to 2.7	0.3	1.3	4.0	ns
			2.7	0.5	1.7	5.0	ns
			3.0 to 3.6	0.5	1.6	3.7	ns
			4.5 to 5.5	0.5	1.3	3.0	ns

#### AC WAVEFORMS

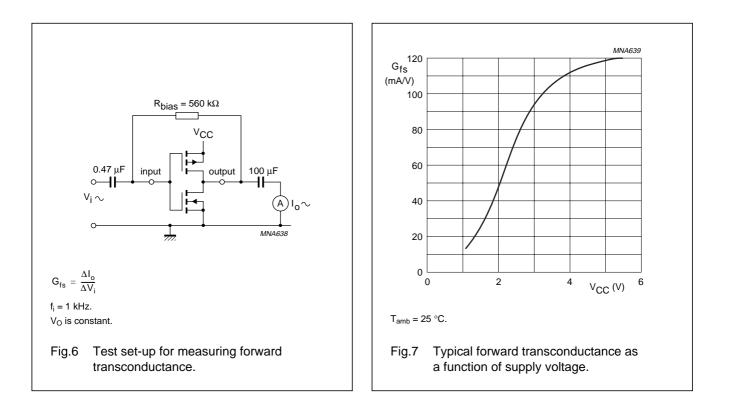


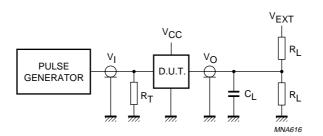
V	Vec Vec		JT
V <sub>cc</sub>	VM	VI	t <sub>r</sub> = t <sub>f</sub>
1.65 to 1.95 V	$0.5 \times V_{CC}$	V <sub>CC</sub>	≤ 2.0 ns
2.3 to 2.7 V	$0.5 \times V_{CC}$	V <sub>CC</sub>	≤ 2.0 ns
2.7 V	1.5 V	2.7 V	≤ 2.5 ns
3.0 to 3.6 V	1.5 V	2.7 V	≤ 2.5 ns
4.5 to 5.5 V	$0.5 \times V_{CC}$	V <sub>CC</sub>	≤ 2.5 ns

 $V_{\text{OL}}$  and  $V_{\text{OH}}$  are typical output voltage drop that occur with the output load.

Fig.5 Input A to output Y propagation delay times.

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V <sub>CC</sub> V <sub>I</sub> C <sub>L</sub> R <sub>L</sub>			V <sub>EXT</sub>			
VCC	•			t <sub>PLH</sub> /t <sub>PHL</sub>	t <sub>PZH</sub> /t <sub>PHZ</sub>	t <sub>PZL</sub> /t <sub>PLZ</sub>
1.65 to 1.95 V	V <sub>CC</sub>	30 pF	1 kΩ	open	GND	$2 \times V_{CC}$
2.3 to 2.7 V	V <sub>CC</sub>	30 pF	500 Ω	open	GND	$2 \times V_{CC}$
2.7 V	2.7 V	50 pF	500 Ω	open	GND	6 V
3.0 to 3.6 V	2.7 V	50 pF	500 Ω	open	GND	6 V
4.5 to 5.5 V	V <sub>CC</sub>	50 pF	500 Ω	open	GND	$2 \times V_{CC}$

Definitions for test circuit:

R<sub>L</sub> = Load resistor.

 $C_L$  = Load capacitance including jig and probe capacitance (see Chapter "AC characteristics").

 $R_T$  = Termination resistance should be equal to the output impedance  $Z_0$  of the pulse generator.

Fig.8 Load circuitry for switching times.

## 74LVC1GU04

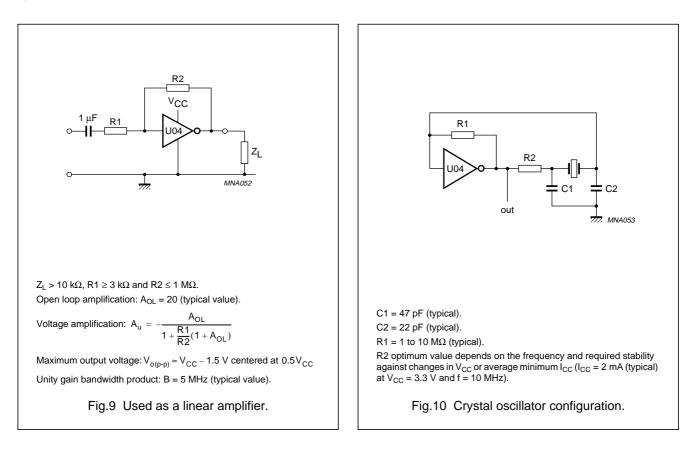
#### **APPLICATION INFORMATION**

Some applications for the 74LVC1GU04 are:

- Linear amplifier (see Fig.9)
- Crystal oscillator (see Fig.10).

#### Remark to the application information.

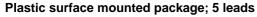
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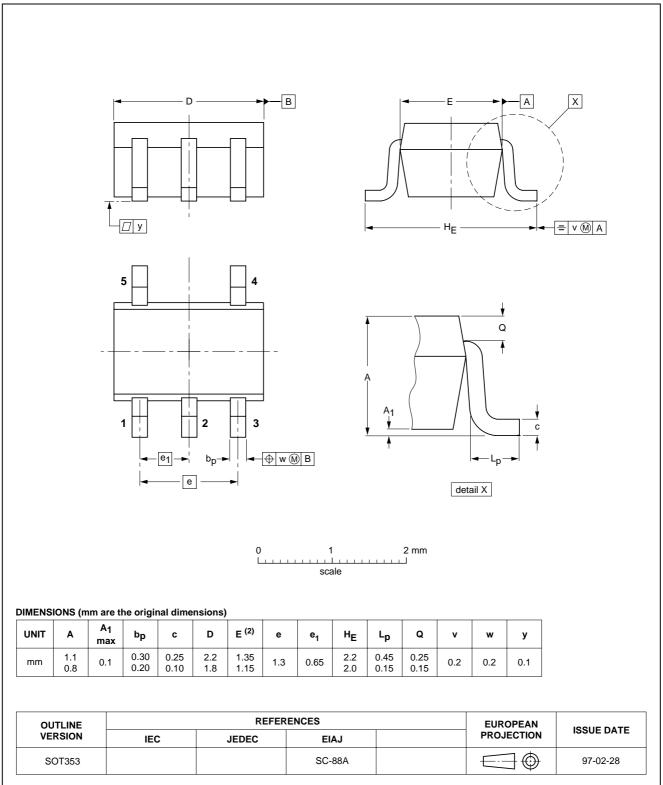


# Product specification

## 74LVC1GU04

#### PACKAGE OUTLINE





## 74LVC1GU04

#### SOLDERING

#### Introduction to soldering surface mount packages

This text gives a very brief insight to a complex technology. A more in-depth account of soldering ICs can be found in our *"Data Handbook IC26; Integrated Circuit Packages"* (document order number 9398 652 90011).

There is no soldering method that is ideal for all surface mount IC packages. Wave soldering can still be used for certain surface mount ICs, but it is not suitable for fine pitch SMDs. In these situations reflow soldering is recommended.

#### **Reflow soldering**

Reflow soldering requires solder paste (a suspension of fine solder particles, flux and binding agent) to be applied to the printed-circuit board by screen printing, stencilling or pressure-syringe dispensing before package placement.

Several methods exist for reflowing; for example, convection or convection/infrared heating in a conveyor type oven. Throughput times (preheating, soldering and cooling) vary between 100 and 200 seconds depending on heating method.

Typical reflow peak temperatures range from 215 to 250 °C. The top-surface temperature of the packages should preferable be kept below 220 °C for thick/large packages, and below 235 °C for small/thin packages.

#### Wave soldering

Conventional single wave soldering is not recommended for surface mount devices (SMDs) or printed-circuit boards with a high component density, as solder bridging and non-wetting can present major problems.

To overcome these problems the double-wave soldering method was specifically developed.

If wave soldering is used the following conditions must be observed for optimal results:

- Use a double-wave soldering method comprising a turbulent wave with high upward pressure followed by a smooth laminar wave.
- For packages with leads on two sides and a pitch (e):
  - larger than or equal to 1.27 mm, the footprint longitudinal axis is preferred to be parallel to the transport direction of the printed-circuit board;
  - smaller than 1.27 mm, the footprint longitudinal axis must be parallel to the transport direction of the printed-circuit board.

The footprint must incorporate solder thieves at the downstream end.

• For packages with leads on four sides, the footprint must be placed at a 45° angle to the transport direction of the printed-circuit board. The footprint must incorporate solder thieves downstream and at the side corners.

During placement and before soldering, the package must be fixed with a droplet of adhesive. The adhesive can be applied by screen printing, pin transfer or syringe dispensing. The package can be soldered after the adhesive is cured.

Typical dwell time is 4 seconds at 250 °C. A mildly-activated flux will eliminate the need for removal of corrosive residues in most applications.

#### Manual soldering

Fix the component by first soldering two diagonally-opposite end leads. Use a low voltage (24 V or less) soldering iron applied to the flat part of the lead. Contact time must be limited to 10 seconds at up to  $300 \,^{\circ}$ C.

When using a dedicated tool, all other leads can be soldered in one operation within 2 to 5 seconds between 270 and 320  $^\circ\text{C}.$ 

## 74LVC1GU04

#### Suitability of surface mount IC packages for wave and reflow soldering methods

PACKAGE	SOLDERING METHOD		
FACKAGE	WAVE	REFLOW <sup>(1)</sup>	
BGA, LFBGA, SQFP, TFBGA	not suitable	suitable	
HBCC, HLQFP, HSQFP, HSOP, HTQFP, HTSSOP, SMS	not suitable <sup>(2)</sup>	suitable	
PLCC <sup>(3)</sup> , SO, SOJ	suitable	suitable	
LQFP, QFP, TQFP	not recommended <sup>(3)(4)</sup>	suitable	
SSOP, TSSOP, VSO	not recommended <sup>(5)</sup>	suitable	

#### Notes

- 1. All surface mount (SMD) packages are moisture sensitive. Depending upon the moisture content, the maximum temperature (with respect to time) and body size of the package, there is a risk that internal or external package cracks may occur due to vaporization of the moisture in them (the so called popcorn effect). For details, refer to the Drypack information in the "Data Handbook IC26; Integrated Circuit Packages; Section: Packing Methods".
- 2. These packages are not suitable for wave soldering as a solder joint between the printed-circuit board and heatsink (at bottom version) can not be achieved, and as solder may stick to the heatsink (on top version).
- 3. If wave soldering is considered, then the package must be placed at a 45° angle to the solder wave direction. The package footprint must incorporate solder thieves downstream and at the side corners.
- 4. Wave soldering is only suitable for LQFP, TQFP and QFP packages with a pitch (e) equal to or larger than 0.8 mm; it is definitely not suitable for packages with a pitch (e) equal to or smaller than 0.65 mm.
- 5. Wave soldering is only suitable for SSOP and TSSOP packages with a pitch (e) equal to or larger than 0.65 mm; it is definitely not suitable for packages with a pitch (e) equal to or smaller than 0.5 mm.

## 74LVC1GU04

DATA SHEET STATUS
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DATA SHEET STATUS <sup>(1)</sup>	PRODUCT STATUS <sup>(2)</sup>	DEFINITIONS
Objective data	Development	This data sheet contains data from the objective specification for product development. Philips Semiconductors reserves the right to change the specification in any manner without notice.
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